

<b>Search Notes</b>				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/814,968	SOHN ET AL.	
				Examiner	Art Unit	
				Yaima Campos	2185	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class      Subclass      Date      Examiner				DATE	EXMR	
				EIC PLUS search	4/13/2006	YC
				PALM and EAST inventor name search	4/13/2006	YC
				Text search within subclasses 711/168,149,150,168 and 365/230.05,189.04,233,230.08,230.03 ,189.05,189.07,230.06	4/13/2006	YC
<b>INTERFERENCE SEARCHED</b>						
Class      Subclass      Date      Examiner						